

Notice of References Cited

Application/Control No.

10/526,245

Applicant(s)/Patent Under
Reexamination
NAKAMURA ET AL.

Examiner

JENNIFER A. SMITH

Art Unit

1793

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
	E	US-			
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	K	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2002320862 A	11-2002	Japan	NIINO et al.	B01J 35/02
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NON-PATENT DOCUMENTS

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